SN54ALS299, SN74ALS299 8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS WITH 3-STATE OUTPUTS

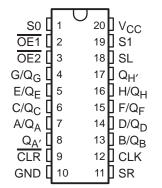
SDAS220B - DECEMBER 1982 - REVISED DECEMBER 1994

- Multiplexed I/O Ports Provide Improved Bit Density
- Four Modes of Operation:
 - Hold (Store)
 - Shift Right
 - Shift Left
 - Load Data
- Operate With Outputs Enabled or at High Impedance
- 3-State Outputs Drive Bus Lines Directly
- Can Be Cascaded for n-Bit Word Lengths
- Direct Overriding Clear
- Applications:
 - Stacked or Push-Down Registers
 - Buffer Storage
 - Accumulator Registers
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

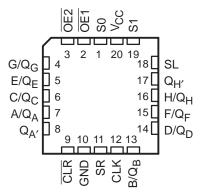
description

These 8-bit universal shift/storage registers feature multiplexed I/O ports to achieve full 8-bit data handling in a single 20-pin package. Two function-select (S0, S1) inputs and two outputenable (OE1, OE2) inputs can be used to choose the modes of operation listed in the function table.

SN54ALS299 . . . J PACKAGE SN74ALS299 . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS299 . . . FK PACKAGE (TOP VIEW)



Synchronous parallel loading is accomplished by taking both S0 and S1 high. This places the 3-state outputs in the high-impedance state and permits data applied on the I/O ports to be clocked into the register. Reading out of the register can be accomplished while the outputs are enabled in any mode. Clearing occurs asynchronously when the clear (CLR) input is low. Taking either OE1 or OE2 high disables the outputs, but has no effect on clearing, shifting, or storing data.

The SN54ALS299 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ALS299 is characterized for operation from 0° C to 70° C.

SN54ALS299, SN74ALS299 8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS WITH 3-STATE OUTPUTS

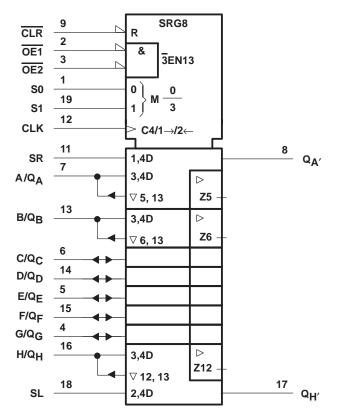
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FUNCTION TABLE

MODE				INP	JTS							I/O P	ORTS				OUTI	PUTS
MODE	CLR	S1	S0	OE1†	OE2†	CLK	SL	SR	A/Q _A	B/QB	C/QC	D/QD	E/QE	F/Q _F	G/Q _G	H/Q _H	$Q_{A'}$	$Q_{H'}$
Clear	L L L	X L H	L X H	L L X	L L X	X X X	X X X	X X X	L L X	L L L	Г Г							
Hold	H H	L X	L X	L L	L L	X L	X X	X X	Q _{A0} Q _{A0}	Q _{B0} Q _{B0}	Q _{C0}	Q _{D0} Q _{D0}	Q _{E0} Q _{E0}	Q _{F0} Q _{F0}	Q _{G0} Q _{G0}	Q _{H0} Q _{H0}	Q _{A0} Q _{A0}	Q _{H0} Q _{H0}
Shift Right	H H	L L	H H	L L	L L	↑	X X	H L	H L	Q _{An} Q _{An}	Q _{Bn} Q _{Bn}	Q _{Cn} Q _{Cn}	Q _{Dn} Q _{Dn}	Q _{En} Q _{En}	Q _{Fn} Q _{Fn}	Q _{Gn} Q _{Gn}	H L	Q _{Gn} Q _{Gn}
Shift Left	H H	H H	L L	L L	L L	↑ ↑	H L	X X	Q _{Bn} Q _{Bn}	Q _{Cn} Q _{Cn}	Q _{Dn} Q _{Dn}	Q _{En} Q _{En}	Q _{Fn} Q _{Fn}	Q _{Gn} Q _{Gn}	Q _{Hn} Q _{Hn}	H L	Q _{Bn} Q _{Bn}	H L
Load	Н	Н	Н	Χ	Χ	1	Х	Χ	а	b	С	d	е	f	g	h	а	h

NOTE: a . . . h = the level of the steady-state input at inputs A through H, respectively. This data is loaded into the flip-flops while the flip-flop outputs are isolated from the I/O terminals.

logic symbol‡



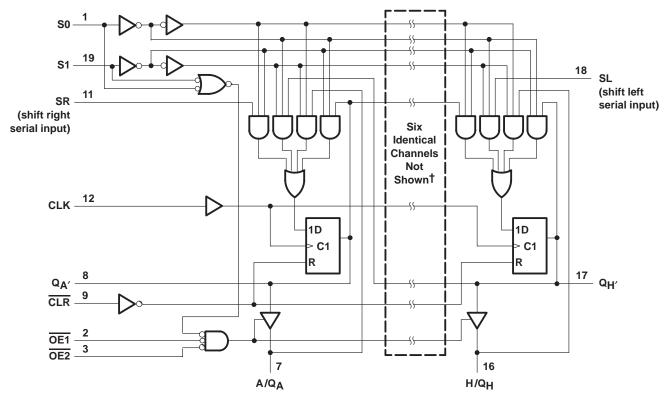
[‡] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



[†] When one or both output-enable inputs are high, the eight I/O terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected.

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logic diagram (positive logic)



 \dagger I/O ports not shown: B/QB (13), C/QC (6), D/QD (14), E/QE (5), F/QF (15), and G/QG (4).

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}		7 V
Input voltage, V _I : All inputs		7 V
I/O ports		5.5 V
Operating free-air temperature range, T _A : \$	SN54ALS299	. −55°C to 125°C
	SN74ALS299	0°C to 70°C
Storage temperature range		. −65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

SN54ALS299, SN74ALS299 8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS WITH 3-STATE OUTPUTS

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recommended operating conditions

				SN	54ALS2	99	SN	74ALS2	99	UNIT
				MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage			4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage			2			2			V
VIL	Low-level input voltage				0.7			0.8	V	
la	High-level output current	Q _A ′ or Q _H ′				-0.4			-0.4	mA
IOH	riigii-ievei output current	Q _A – Q _H				-1			MAX 5.5 0.8	IIIA
la.	Low lovel output ourrent	Q _A ′ or Q _H ′				4			8	mA
IOL	Low-level output current	Q _A – Q _H				12			24	IIIA
TA	Operating free-air temperature			-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	ARAMETER	TEST CO	NOTIONS	SN	54ALS2	99	SN	UNIT		
	ARAWETER	lesi co	NDITIONS	MIN	TYP [†]	MAX	MIN	TYP†	MAX	UNII
٧ıK		V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.5			-1.5	V
	All outputs	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		
Vон	Q _A – Q _H	V _{CC} = 4.5 V	$I_{OH} = -1 \text{ mA}$	2.4	3.3					V
	QA - QH	VCC = 4.5 V	$I_{OH} = -2.6 \text{ mA}$				2.4	3.2		
	Q _A , or Q _H ,	V _{CC} = 4.5 V	$I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	
\/o;	QA' OI QH'	VCC = 4.5 V	$I_{OL} = 8 \text{ mA}$					0.35	0.5	V
VOL	Q _A – Q _H	V _{CC} = 4.5 V	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	
	QA - QH	VCC = 4.5 V	I _{OL} = 24 mA					0.35	0.5	
1.	A – H	V _{CC} = 5.5 V	V _I = 5.5 V			0.1			0.1	mA
Ħ	Any others	VCC = 5.5 V	V _I = 7 V			0.1			0.1	ША
l _{IH} ‡		V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
. +	S0, S1, SR, SL	V 55V	V: 0.4.V			-0.2			-0.2	A
I _{IL} ‡	Any others	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.1			-0.1	mA
	Q _A ' or Q _H '	V F-V	\/a 2.25\/	-15		-70	-15		-70	mA
IO§	Q _A – Q _H	V _{CC} = 5.5 V,	$V_0 = 2.25 \text{ V}$	-20		-112	-30		-112	MA
			Outputs high		15	28		15	28	
ICC		V _{CC} = 5.5 V	Outputs low		22	38		22	38	mA
			Outputs disabled		23	40		23	40	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

 $[\]ddagger$ For I/O ports (Q_A-Q_H), the parameters I_{IH} and I_{IL} include the off-state output current.

^{\$} The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

				SN54A	LS299	SN74A	LS299	UNIT
		MIN	MAX	MIN	MAX	OMIT		
fclock	Clock frequency (at 50% duty cycle)	0	17	0	30	MHz		
t _w	Pulse duration	CLK high or low		22		16.5		
	Fulse duration	CLR low	12		10		ns	
		S0 or S1	25		20			
l.	Setup time before CLK↑	0 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 -	High	18		16		
t _{su}		Serial or parallel data	15		6		ns	
	Inactive-state setup time before CLK↑†	CLR	15		15			
th	Hold time after CLK↑	S0 or S1	0		0			
	HOIG LITTLE AILER CLK	Serial or parallel data	0		0		ns	

[†] Inactive-state setup time is also referred to as recovery time.

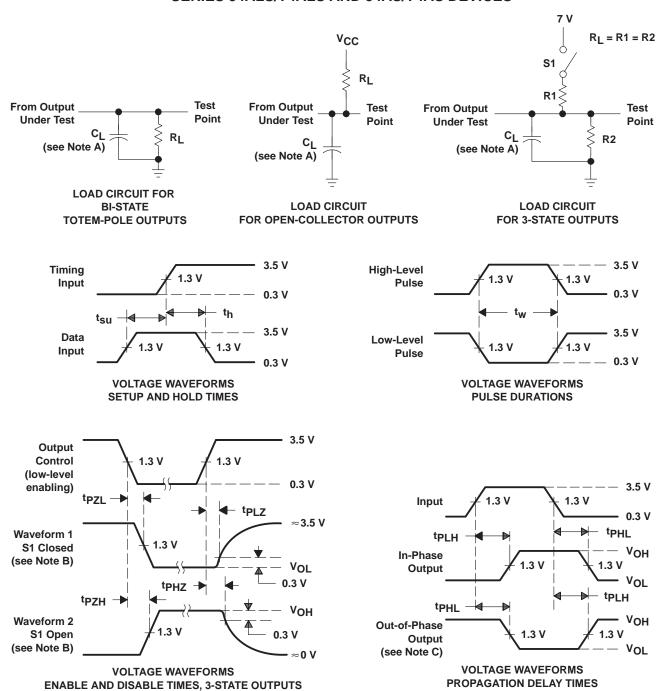
switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R1 R2 T _A		UNIT		
			SN54A	LS299	SN74ALS299		
			MIN	MAX	MIN	MAX	
f _{max}			17		30		MHz
^t PLH	CLK	0.00	2	19	4	13	ns ns
^t PHL	CLK	Q _A –Q _H	4	25	7	19	
t _{PLH}	CLK	00**0	2	21	5	15	
t _{PHL}	CLK	Q _A ′ or Q _H ′	4	25	8	18	
4	CLR	Q _A -Q _H	6	29	6	22	20
^t PHL	CLR	Q _A ′ or Q _H ′	6	29	6	22	ns
^t PZH	OE1, OE2	0 0	5	22	6	16	
t _{PZL}	OE1, OE2	Q_A-Q_H	6	27	8	22	ns
^t PZH	CO C4	0.0.	5	27	7	17	20
tPZL	S0, S1	Q_A-Q_H	6	26	8	22	ns
t _{PHZ}	OF4 OF2	0.0.	1	15	1	8	ns
t _{PLZ}	OE1, OE2	Q_A-Q_H	4	38	5	15	
^t PHZ	S0, S1	Q _A -Q _H	1	16	1	12	ne
^t PLZ	30, 31	ΨΑ ⁻ ΨΗ	4	34	8	25	ns

[‡] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, t_{Γ} = t_{f} = 2 ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms







17-Mar-2017

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
83021012A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	83021012A SNJ54ALS 299FK	Samples
8302101RA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8302101RA SNJ54ALS299J	Samples
8302101SA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8302101SA SNJ54ALS299W	Samples
SN74ALS299DW	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS299	Samples
SN74ALS299N	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN74ALS299N	Samples
SNJ54ALS299FK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	83021012A SNJ54ALS 299FK	Samples
SNJ54ALS299J	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8302101RA SNJ54ALS299J	Samples
SNJ54ALS299W	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8302101SA SNJ54ALS299W	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.





17-Mar-2017

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54ALS299, SN74ALS299:

Catalog: SN74ALS299

Military: SN54ALS299

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



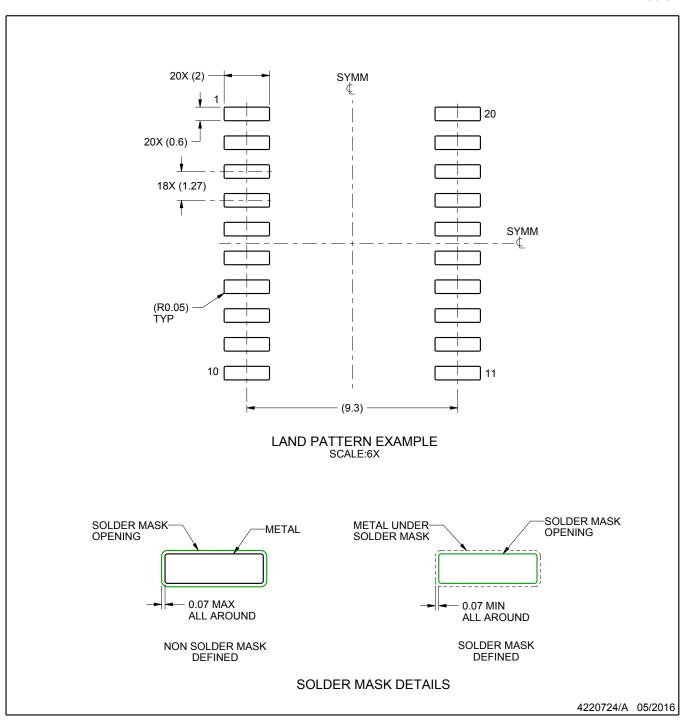
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

 D. Index point is provided on cap for terminal identification only.

 E. Falls within Mil—Std 1835 GDFP2—F20



FK (S-CQCC-N**)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004



14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

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